TEST REPORT

Reference No. : WTS14S0716067E

FCC ID : 2AANE-BTS710

Applicant.....: Advance Bright Limited

Address.....: Room 1206, Tower 2, Silvercord, 30 Canton Road, Tsim Sha Tsui,

Kowloon, HongKong

Manufacturer : Fu Yuan Electronics Shenzhen Co., Ltd

Address.....: 1 Minzhu 99 Industrial City, Shajing Western Industrial Park, Ban An

District, Shenzhen, China

Product Name.....: Protable Bluetooth Speaker

Model No. : BTS710

Standards...... : FCC CFR47 Part 15 Section 15.247:2012

Date of Receipt sample : Jul. 10, 2014

Date of Test : Jul. 11~16, 2014

Date of Issue..... : Jul. 17, 2014

Test Result..... : Pass *

*Remarks:

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of compiler and approver.

Prepared By:

Waltek Services (Shenzhen) Co., Ltd.

Address: 1/F., Fukangtai Building, West Baima Road, Songgang Street, Baoan District, Shenzhen, Guangdong, China

Testing location: The same as above Tel:+86-755-83551033 Fax:+86-755-83552400

Compiled by:

Approved by:

Zero Zhou / Project Engineer

Philo Zhong / Manager

Thilo zhang

Reference No.: WTS14S0716067E Page 2 of 65

2 Test Summary

Test Items	Test Requirement	Result	
	15.205(a)		
Radiated Spurious Emissions	15.209	PASS	
	15.247(d)		
David adva	15.247(d)	DAGG	
Band edge	15.205(a)	PASS	
Conduct Emission	15.207	PASS	
20dB Bandwidth	15.247(a)(1)	PASS	
Maximum Peak Output Power	15.247(b)(1)	PASS	
Frequency Separation	15.247(a)(1)	PASS	
Number of Hopping Frequency	15.247(a)(1)(iii)	PASS	
Dwell time	15.247(a)(1)(iii)	PASS	
Maximum Permissible Exposure	4.4007(1)/(4)	B400	
(Exposure of Humans to RF Fields)	1.1307(b)(1)	PASS	

3 Contents

2 TEST SUMMARY	90
3 CONTENTS 4 GENERAL INFORMATION. 4.1 GENERAL DESCRIPTION OF E.U.T. 4.2 DETAILS OF E.U.T. 4.3 CHANNEL LIST. 4.4 TEST MODE. 4.5 TEST FACILITY. 5 EQUIPMENT USED DURING TEST. 5.1 EQUIPMENTS LIST. 5.2 DESCRIPTION OF SUPPORT UNITS. 5.3 MEASUREMENT UNCERTAINTY. 5.4 TEST EQUIPMENT CALIBRATION. 6 CONDUCTED EMISSION. 6.1 E.U.T. OPERATION. 6.2 EUT SETUP. 6.3 MEASUREMENT DESCRIPTION. 6.4 CONDUCTED EMISSION TEST RESULT. 7 RADIATED SPURIOUS EMISSIONS. 7.1 EUT OPERATION. 7.2 TEST SETUP. 7.3 SPECTRUM ANALYZER SETUP. 7.4 TEST PROCEDURE. 8.1 TEST PROCEDURE. 8.2 TEST RESULT. 9 20 DB BANDWIDTH MEASUREMENT. 9.1 TEST PROCEDURE. 9.2 TEST RESULT.	1
4.1 GENERAL INFORMATION 4.1 GENERAL DESCRIPTION OF E.U.T. 4.2 DETAILS OF E.U.T. 4.3 CHANNEL LIST 4.4 TEST MODE 4.5 TEST FACILITY 5 EQUIPMENT USED DURING TEST 5.1 EQUIPMENTS LIST 5.2 DESCRIPTION OF SUPPORT UNITS 5.3 MEASUREMENT UNCERTAINTY 5.4 TEST EQUIPMENT CALIBRATION 6 CONDUCTED EMISSION 6.1 E.U.T. OPERATION 6.2 EUT SETUP 6.3 MEASUREMENT DESCRIPTION 6.4 CONDUCTED EMISSION TEST RESULT 7 RADIATED SPURIOUS EMISSIONS 7.1 EUT OPERATION 7.2 TEST SETUP 7.3 SPECTRUM ANALYZER SETUP 7.4 TEST PROCEDURE 7.5 SUMMARY OF TEST RESULTS 8 BAND EDGE MEASUREMENT 8.1 TEST PROCEDURE 8.2 TEST RESULT 9 20 DB BANDWIDTH MEASUREMENT 9.1 TEST PROCEDURE 9.2 TEST RESULT 10 MAXIMUM PEAK OUTPUT POWER 10.1 TEST PROCEDURE	2
4.1 GENERAL DESCRIPTION OF E.U.T. 4.2 DETAILS OF E.U.T. 4.3 CHANNEL LIST. 4.4 TEST MODE 4.5 TEST FACILITY. 5 EQUIPMENT USED DURING TEST. 5.1 EQUIPMENTS LIST. 5.2 DESCRIPTION OF SUPPORT UNITS. 5.3 MEASUREMENT UNCERTAINTY. 5.4 TEST EQUIPMENT CALIBRATION. 6 CONDUCTED EMISSION. 6.1 E.U.T. OPERATION. 6.2 EUT SETUP 6.3 MEASUREMENT DESCRIPTION. 6.4 CONDUCTED EMISSION TEST RESULT. 7 RADIATED SPURIOUS EMISSIONS 7.1 EUT OPERATION 7.2 TEST SETUP 7.3 SPECTRUM ANALYZER SETUP 7.4 TEST PROCEDURE 7.5 SUMMARY OF TEST RESULTS 8 BAND EDGE MEASUREMENT 8.1 TEST PROCEDURE 8.2 TEST RESULT 9 20 DB BANDWIDTH MEASUREMENT 9.1 TEST PROCEDURE 9.2 TEST RESULT 10 MAXIMUM PEAK OUTPUT POWER 10.1 TEST PROCEDURE 10.1 TEST PROCEDURE	3
4.2 DETAILS OF E.U.T. 4.3 CHANNEL LIST. 4.4 TEST MODE. 4.5 TEST FACILITY. 5 EQUIPMENT USED DURING TEST. 5.1 EQUIPMENTS LIST. 5.2 DESCRIPTION OF SUPPORT UNITS. 5.3 MEASUREMENT UNCERTAINTY. 5.4 TEST EQUIPMENT CALIBRATION. 6 CONDUCTED EMISSION. 6.1 E.U.T. OPERATION. 6.2 EUT SETUP. 6.3 MEASUREMENT DESCRIPTION. 6.4 CONDUCTED EMISSION TEST RESULT. 7 RADIATED SPURIOUS EMISSIONS. 7.1 EUT OPERATION. 7.2 TEST SETUP. 7.3 SPECTRUM ANALYZER SETUP 7.4 TEST PROCEDURE. 8.1 TEST PROCEDURE 8.2 TEST RESULT. 9 20 DB BANDWIDTH MEASUREMENT. 9.1 TEST PROCEDURE 9.2 TEST RESULT. 10 MAXIMUM PEAK OUTPUT POWER. 10.1 TEST PROCEDURE.	PAGE
4.3 CHANNEL LIST	
4.4 TEST MODE 4.5 TEST FACILITY 5 EQUIPMENT USED DURING TEST 5.1 EQUIPMENTS LIST 5.2 DESCRIPTION OF SUPPORT UNITS 5.3 MEASUREMENT UNCERTAINTY 5.4 TEST EQUIPMENT CALIBRATION. 6 CONDUCTED EMISSION 6.1 E.U.T. OPERATION 6.2 EUT SETUP 6.3 MEASUREMENT DESCRIPTION 6.4 CONDUCTED EMISSION TEST RESULT 7 RADIATED SPURIOUS EMISSIONS. 7.1 EUT OPERATION. 7.2 TEST SETUP 7.3 SPECTRUM ANALYZER SETUP 7.4 TEST PROCEDURE 7.5 SUMMARY OF TEST RESULTS. 8 BAND EDGE MEASUREMENT 8.1 TEST PROCEDURE 8.2 TEST RESULT. 9 20 DB BANDWIDTH MEASUREMENT 9.1 TEST PROCEDURE 9.2 TEST RESULT. 10 MAXIMUM PEAK OUTPUT POWER 10.1 TEST PROCEDURE	
4.5 TEST FACILITY	
5.1 EQUIPMENTS LIST	
5.2 DESCRIPTION OF SUPPORT UNITS 5.3 MEASUREMENT UNCERTAINTY 5.4 TEST EQUIPMENT CALIBRATION 6 CONDUCTED EMISSION 6.1 E.U.T. OPERATION 6.2 EUT SETUP	7
5.3 MEASUREMENT UNCERTAINTY 5.4 TEST EQUIPMENT CALIBRATION 6 CONDUCTED EMISSION 6.1 E.U.T. OPERATION 6.2 EUT SETUP 6.3 MEASUREMENT DESCRIPTION 6.4 CONDUCTED EMISSION TEST RESULT 7 RADIATED SPURIOUS EMISSIONS 7.1 EUT OPERATION 7.2 TEST SETUP 7.3 SPECTRUM ANALYZER SETUP 7.4 TEST PROCEDURE 7.5 SUMMARY OF TEST RESULTS 8 BAND EDGE MEASUREMENT 8.1 TEST PROCEDURE 8.2 TEST RESULT 9 20 DB BANDWIDTH MEASUREMENT 9.1 TEST PROCEDURE 9.2 TEST RESULT 10 MAXIMUM PEAK OUTPUT POWER 10.1 TEST PROCEDURE	7
5.4 TEST EQUIPMENT CALIBRATION 6. CONDUCTED EMISSION 6.1 E.U.T. OPERATION 6.2 EUT SETUP 6.3 MEASUREMENT DESCRIPTION 6.4 CONDUCTED EMISSION TEST RESULT 7 RADIATED SPURIOUS EMISSIONS 7.1 EUT OPERATION. 7.2 TEST SETUP 7.3 SPECTRUM ANALYZER SETUP 7.4 TEST PROCEDURE 7.5 SUMMARY OF TEST RESULTS 8 BAND EDGE MEASUREMENT 8.1 TEST PROCEDURE 8.2 TEST RESULT 9 20 DB BANDWIDTH MEASUREMENT 9.1 TEST PROCEDURE 9.2 TEST RESULT 10 MAXIMUM PEAK OUTPUT POWER 10.1 TEST PROCEDURE	7
6 CONDUCTED EMISSION 6.1 E.U.T. OPERATION 6.2 EUT SETUP	
6.1 E.U.T. OPERATION 6.2 EUT SETUP 6.3 MEASUREMENT DESCRIPTION 6.4 CONDUCTED EMISSION TEST RESULT 7 RADIATED SPURIOUS EMISSIONS 7.1 EUT OPERATION 7.2 TEST SETUP 7.3 SPECTRUM ANALYZER SETUP 7.4 TEST PROCEDURE 7.5 SUMMARY OF TEST RESULTS 8 BAND EDGE MEASUREMENT 8.1 TEST PROCEDURE 8.2 TEST RESULT 9 20 DB BANDWIDTH MEASUREMENT 9.1 TEST PROCEDURE 9.2 TEST RESULT 10 MAXIMUM PEAK OUTPUT POWER 10.1 TEST PROCEDURE	
6.2 EUT SETUP 6.3 MEASUREMENT DESCRIPTION 6.4 CONDUCTED EMISSION TEST RESULT 7 RADIATED SPURIOUS EMISSIONS 7.1 EUT OPERATION 7.2 TEST SETUP 7.3 SPECTRUM ANALYZER SETUP 7.4 TEST PROCEDURE 7.5 SUMMARY OF TEST RESULTS 8 BAND EDGE MEASUREMENT 8.1 TEST PROCEDURE 8.2 TEST RESULT 9 20 DB BANDWIDTH MEASUREMENT 9.1 TEST PROCEDURE 9.2 TEST RESULT 10 MAXIMUM PEAK OUTPUT POWER 10.1 TEST PROCEDURE	
6.3 MEASUREMENT DESCRIPTION 6.4 CONDUCTED EMISSION TEST RESULT 7 RADIATED SPURIOUS EMISSIONS 7.1 EUT OPERATION 7.2 TEST SETUP 7.3 SPECTRUM ANALYZER SETUP 7.4 TEST PROCEDURE 7.5 SUMMARY OF TEST RESULTS. 8 BAND EDGE MEASUREMENT 8.1 TEST PROCEDURE 8.2 TEST RESULT 9 20 DB BANDWIDTH MEASUREMENT 9.1 TEST PROCEDURE 9.2 TEST RESULT 10 MAXIMUM PEAK OUTPUT POWER 10.1 TEST PROCEDURE	
6.4 CONDUCTED EMISSION TEST RESULT 7 RADIATED SPURIOUS EMISSIONS	
7.1 EUT OPERATION 7.2 TEST SETUP 7.3 SPECTRUM ANALYZER SETUP 7.4 TEST PROCEDURE 7.5 SUMMARY OF TEST RESULTS 8 BAND EDGE MEASUREMENT 8.1 TEST PROCEDURE 8.2 TEST RESULT 9 20 DB BANDWIDTH MEASUREMENT 9.1 TEST PROCEDURE 9.2 TEST RESULT 10 MAXIMUM PEAK OUTPUT POWER 10.1 TEST PROCEDURE	
7.2 TEST SETUP	12
7.3 SPECTRUM ANALYZER SETUP 7.4 TEST PROCEDURE 7.5 SUMMARY OF TEST RESULTS 8 BAND EDGE MEASUREMENT 8.1 TEST PROCEDURE 8.2 TEST RESULT 9 20 DB BANDWIDTH MEASUREMENT 9.1 TEST PROCEDURE 9.2 TEST RESULT 10 MAXIMUM PEAK OUTPUT POWER 10.1 TEST PROCEDURE	12
7.4 TEST PROCEDURE 7.5 SUMMARY OF TEST RESULTS 8 BAND EDGE MEASUREMENT 8.1 TEST PROCEDURE 8.2 TEST RESULT 9 20 DB BANDWIDTH MEASUREMENT 9.1 TEST PROCEDURE 9.2 TEST RESULT 10 MAXIMUM PEAK OUTPUT POWER 10.1 TEST PROCEDURE	
7.5 SUMMARY OF TEST RESULTS 8 BAND EDGE MEASUREMENT	
8 BAND EDGE MEASUREMENT 8.1 TEST PROCEDURE 8.2 TEST RESULT 9 20 DB BANDWIDTH MEASUREMENT 9.1 TEST PROCEDURE 9.2 TEST RESULT 10 MAXIMUM PEAK OUTPUT POWER 10.1 TEST PROCEDURE	
8.1 TEST PROCEDURE	
8.2 TEST RESULT 9 20 DB BANDWIDTH MEASUREMENT	
9.1 TEST PROCEDURE	
9.2 TEST RESULT	26
10.1 TEST PROCEDURE	26
10.1 Test Procedure	26
	32
10.2 Test Result	32
	32
11 HOPPING CHANNEL SEPARATION	38
11.1 Test Procedure	
11.2 TEST RESULT	
12 NUMBER OF HOPPING FREQUENCY	
12.1 TEST PROCEDURE	
12.2 TEST RESULT	
13 DWELL TIME	
13.1 TEST PROCEDURE	46 46

Reference No.: WTS14S0716067E Page 4 of 65

14	ANTENNA REQUIREMENT						
15	RF EX	XPOSURE	53				
		REQUIREMENTSTHE PROCEDURES / LIMITMPE CALCULATION METHOD	53				
16	PHOT	FOGRAPHS -MODEL BTS710 TEST SETUP	55				
	16.1 16.2	PHOTOGRAPH – CONDUCTED EMISSION TEST SETUPPHOTOGRAPH – RADIATION SPURIOUS EMISSION TEST SETUP					
17	PHOT	FOGRAPHS - CONSTRUCTIONAL DETAILS	57				
	17.1 17.2	MODEL BTS710- EXTERNAL VIEW					

Reference No.: WTS14S0716067E Page 5 of 65

4 General Information

4.1 General Description of E.U.T.

Product Name : Protable Bluetooth Speaker

Model No. : BTS710

Operation Frequency : 2402MHz ~ 2480MHz, 79 channels in total

Type of Modulation : GFSK, Pi/4DQPSK, 8DPSK

The lowest oscillator : 16MHz

Antenna installation : Internal permanent antenna

Antenna Gain : 0dBi

4.2 Details of E.U.T.

Technical Data : (1) DC 5V powered by USB charging

(2) DC 3.6V, 2.2Ah by battery

4.3 Channel List

Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)
0	2402	1	2403	2	2404	3	2405
4	2406	5	2407	6	2408	7	2409
8	2410	9	2411	10	2412	11	2413
12	2414	13	2415	14	2416	15	2417
16	2418	17	2419	18	2420	19	2421
20	2422	21	2423	22	2424	23	2425
24	2426	25	2427	26	2428	27	2429
28	2430	29	2431	30	2432	31	2433
32	2434	33	2435	34	2436	35	2437
36	2438	37	2439	38	2440	39	2441
40	2442	41	2443	42	2444	43	2445
44	2446	45	2447	46	2448	47	2449
48	2450	49	2451	50	2452	51	2453
52	2454	53	2455	54	2456	55	2457
56	2458	57	2459	58	2460	59	2461
60	2462	61	2463	62	2464	63	2465
64	2466	65	2467	66	2468	67	2469
68	2470	69	2471	70	2472	71	2473
72	2474	73	2475	74	2476	75	2477
76	2478	77	2479	78	2480	-	-

Reference No.: WTS14S0716067E Page 6 of 65

4.4 Test Mode

All test mode(s) and condition(s) mentioned were considered and evaluated respectively by performing full tests, the worst data were recorded and reported.

Test mode	Low channel	Middle channel	High channel
Transmitting	2402MHz	2441MHz	2480MHz

4.5 Test Facility

The test facility has a test site registered with the following organizations:

IC – Registration No.: 7760A-1

Waltek Services (Shenzhen) Co., Ltd. has been registered and fully described in a report filed with the Industry Canada. The acceptance letter from the Industry Canada is maintained in our files. Registration 7760A-1, July 12, 2012.

• FCC – Registration No.: 880581

Waltek Services (Shenzhen) Co., Ltd. EMC Laboratory `has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 880581, April 29, 2014.

Reference No.: WTS14S0716067E Page 7 of 65

5 Equipment Used during Test

5.1 Equipments List

3.1	5.1 Equipments List									
Conducted Emissions										
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date				
1.	EMI Test Receiver	R&S	ESCI	101155	Sep.18,2013	Sep.17,2014				
2.	LISN	SCHWARZBECK	NSLK 8128	8128-289	Sep.18,2013	Sep.17,2014				
3.	Limiter	York	MTS-IMP-136	261115-001- 0024	Sep.18,2013	Sep.17,2014				
4.	Cable	LARGE	RF300	-	Sep.18,2013	Sep.17,2014				
3m Se	mi-anechoic Chamb	oer for Radiation E	Emissions							
Item	Equipment	Manufacturer	Model No.	Model No. Serial No.		Calibration Due Date				
1	EMC Analyzer	Agilent	E7405A	MY45114943	Sep.18,2013	Sep.17,2014				
2	Active Loop Antenna	Beijing Dazhi	ZN30900A	-	Sep.18,2013	Sep.17,2014				
3	Trilog Broadband Antenna	SCHWARZBECK	VULB9163	VULB9163 336		Apr.18,2015				
4	Coaxial Cable (below 1GHz)	Тор	TYPE16(13M)	-	Sep.18,2013	Sep.17,2014				
5	Broad-band Horn Antenna	SCHWARZBECK	BBHA 9120 D	667	Apr.19,2014	Apr.18,2015				
6	Broad-band Horn Antenna	SCHWARZBECK	BBHA 9170	335	Apr.19,2014	Apr.18,2015				
7	Broadband Preamplifier	COMPLIANCE DIRECTION	PAP-1G18	2004	Mar.17,2014	Mar.16,2015				
8	Coaxial Cable (above 1GHz)	Тор	1GHz-25GHz	EW02014-7	Apr.10,2014	Apr.09,2015				
RF Co	nducted Testing									
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date				
1.	EMC Analyzer	R&S	ESCI	101155	Sep.18,2013	Sep.17,2014				
2.	Humidity Chamber	GF	GTH-225-40- 1P	IAA061213	May 16,2014	May 15,2015				
3.	DC Power Supply	EVERFINE	WY305	1004002	Apr.11,2014	Apr.10,2015				

5.2 Description of Support Units

Equipment	Manufacturer	Model No.	Series No.		
Computer	Lenovo	T4900V	0100640332		
MacBook Air	APPLE	A1465 (EW03039-1)	C17KTQDNF5N7		

Reference No.: WTS14S0716067E Page 8 of 65

5.3 Measurement Uncertainty

Parameter	Uncertainty
Radio Frequency	$\pm 1 \times 10^{-6}$
RF Power	± 1.0 dB
RF Power Density	± 2.2 dB
Dadioted Courious Emissions toot	± 5.03 dB (Bilog antenna 30M~1000MHz)
Radiated Spurious Emissions test	± 5.47 dB (Horn antenna 1000M~25000MHz)
Conducted Spurious Emissions test	± 3.64 dB (AC mains 150KHz~30MHz)

5.4 Test Equipment Calibration

All the test equipments used are valid and calibrated by CEPREI Certification Body that address is No.110 Dongguan Zhuang RD. Guangzhou, P.R.China.

Reference No.: WTS14S0716067E Page 9 of 65

6 Conducted Emission

Test Requirement: FCC CFR 47 Part 15 Section 15.207

Test Method: ANSI C63.4:2003

Test Result: PASS

Frequency Range: 150kHz to 30MHz

Class/Severity: Class B

Limit: 66-56 dB_µV between 0.15MHz & 0.5MHz

56 dB μ V between 0.5MHz & 5MHz 60 dB μ V between 5MHz & 30MHz

Detector: Peak for pre-scan (9kHz Resolution Bandwidth)

6.1 E.U.T. Operation

Operating Environment:

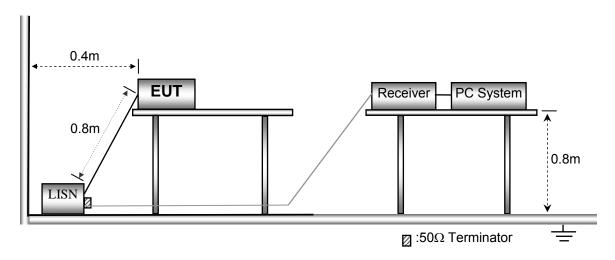
Temperature: 22.8 °C
Humidity: 51.3 % RH
Atmospheric Pressure: 101.2kPa

EUT Operation:

The test was performed in transmitting mode, the test data were shown in the report.

6.2 EUT Setup

The conducted emission tests were performed using the setup accordance with the ANSI C63.4:2003.



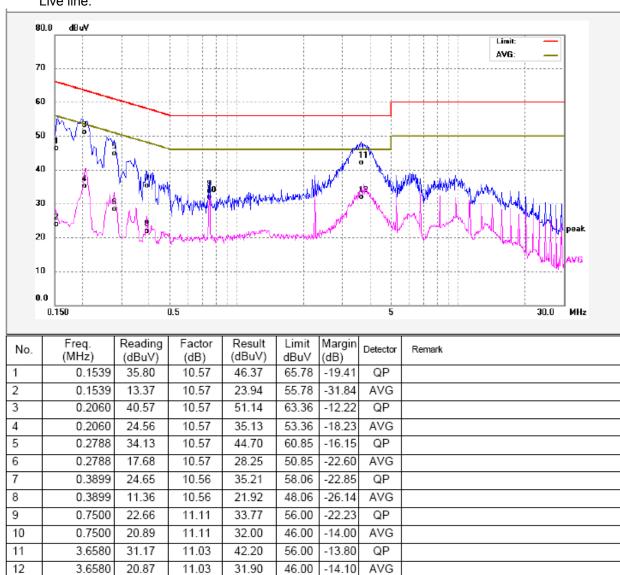
6.3 Measurement Description

The maximised peak emissions from the EUT was scanned and measured for both the Live and Neutral Lines. Quasi-peak & average measurements were performed if peak emissions were within 6dB of the average limit line.

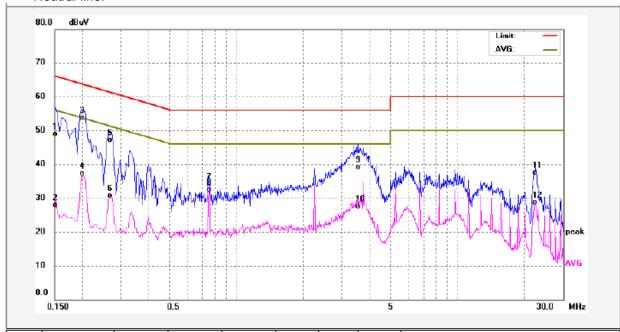
Reference No.: WTS14S0716067E Page 10 of 65

6.4 Conducted Emission Test Result

Live line:



Neutral line:



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit dBuV	Margin (dB)	Detector	Remark
1	0.1500	38.29	10.57	48.86	65.99	-17.13	QP	
2	0.1500	17.31	10.57	27.88	55.99	-28.11	AVG	
3	0.1980	43.18	10.57	53.75	63.69	-9.94	QP	
4	0.1980	26.76	10.57	37.33	53.69	-16.36	AVG	
5	0.2660	36.56	10.57	47.13	61.24	-14.11	QP	
6	0.2660	20.23	10.57	30.80	51.24	-20.44	AVG	
7	0.7500	23.06	11.11	34.17	56.00	-21.83	QP	
8	0.7500	21.37	11.11	32.48	46.00	-13.52	AVG	
9	3.5340	28.12	11.06	39.18	56.00	-16.82	QP	
10	3.5340	16.39	11.06	27.45	46.00	-18.55	AVG	
11	22.4220	26.12	11.44	37.56	60.00	-22.44	QP	
12	22.4220	17.24	11.44	28.68	50.00	-21.32	AVG	

Reference No.: WTS14S0716067E Page 12 of 65

7 Radiated Spurious Emissions

Test Requirement: FCC CFR47 Part 15 Section 15.209 & 15.247

Test Method: DA 00-705
Test Result: PASS
Measurement Distance: 3m

Limit:

Limit	Field Stre	nath	Field Strength Limit at 3m Measurement Dist			
Frequency (MHz)	uV/m Distance (m)		uV/m	dBuV/m		
0.009 ~ 0.490	2400/F(kHz)	300	10000 * 2400/F(kHz)	20log ^{(2400/F(kHz))} + 80		
0.490 ~ 1.705	24000/F(kHz)	30	100 * 24000/F(kHz)	20log ^{(24000/F(kHz))} + 40		
1.705 ~ 30	30	30	100 * 30	20log ⁽³⁰⁾ + 40		
30 ~ 88	100	3	100	20log ⁽¹⁰⁰⁾		
88 ~ 216	150	3	150	20log ⁽¹⁵⁰⁾		
216 ~ 960	200	3	200	20log ⁽²⁰⁰⁾		
Above 960	500	3	500	20log ⁽⁵⁰⁰⁾		

7.1 EUT Operation

Operating Environment:

Temperature: 22.5 °C
Humidity: 51.9 % RH
Atmospheric Pressure: 101.2kPa

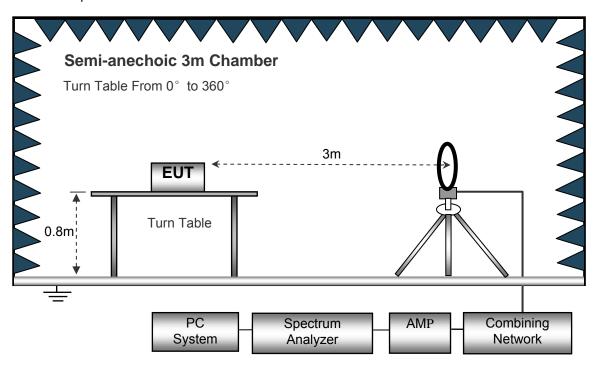
EUT Operation:

The test was performed in transmitting mode, the test data were shown in the report.

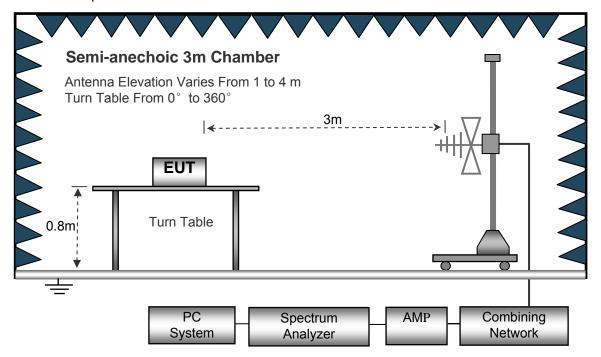
7.2 Test Setup

The radiated emission tests were performed in the 3m Semi- Anechoic Chamber test site, using the setup accordance with the ANSI C63.4: 2003.

The test setup for emission measurement below 30MHz.



The test setup for emission measurement from 30 MHz to 1 GHz.



Anechoic 3m Chamber Antenna Elevation Varies From 1 to 4 m Turn Table From 0 $^{\circ}$ to 360 $^{\circ}$ 3m H **EUT** 0.8m Turn Table Absorbers PC Combining Spectrum AMP Network System Analyzer

The test setup for emission measurement above 1 GHz.

7.3 Spectrum Analyzer Setup

Below 30MHz		
	Sweep Speed	. Auto
	IF Bandwidth	.10kHz
	Video Bandwidth	.10kHz
	Resolution Bandwidth	.10kHz
30MHz ~ 1GHz	<u>z</u>	
	Sweep Speed	. Auto
	Detector	.PK
	Resolution Bandwidth	.100kHz
	Video Bandwidth	.300kHz
Above 1GHz		
	Sweep Speed	. Auto
	Detector	.PK
	Resolution Bandwidth	.1MHz
	Video Bandwidth	.3MHz
	Detector	Ave.
	Resolution Bandwidth	.1MHz
	Video Bandwidth	.10Hz

Reference No.: WTS14S0716067E Page 15 of 65

7.4 Test Procedure

- 1. The EUT is placed on a turntable, which is 0.8m above ground plane.
- 2. The turntable shall be rotated for 360 degrees to determine the position of maximum emission level.
- 3. EUT is set 3m away from the receiving antenna, which is moved from 1m to 4m to find out the maximum emissions. The spectrum was investigated from the lowest radio frequency signal generated in the device, without going below 9 kHz, up to the tenth harmonic of the highest fundamental frequency or to 40 GHz, whichever is lower.
- 4. Maximum procedure was performed on the six highest emissions to ensure EUT compliance.
- 5. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
- 6. Repeat above procedures until the measurements for all frequencies are complete.
- 7. The radiation measurements are tested under 3-axes(X,Y,Z) position(X denotes lying on the table, Y denotes side stand and Z denotes vertical stand), After pre-test, It was found that the worse radiation emission was get at the X position. So the data shown was the X position only.

Reference No.: WTS14S0716067E Page 16 of 65

7.5 Summary of Test Results

Test Frequency: 16MHz~30MHz

The measurements were more than 20 dB below the limit and not reported.

Test Frequency: 30MHz ~ 18GHz

Remark: only the worst data (GFSK modulation mode) were reported.

	Receiver		Turn	RX An	tenna	Corrected	Corrected		
Frequency Reading		Detector	table Angle	Height	Polar	Factor	Amplitude	Limit	Margin
(MHz)	(dBµV)	(PK/QP/Ave)	Degree	(m)	(H/V)	(dB)	(dBµV/m)	(dBµV/m)	(dB)
GFSK Low Channel									
100.47	21.43	QP	2	1.0	Н	14.15	35.58	40.00	-4.42
100.47	17.65	QP	346	2.0	V	14.15	31.80	40.00	-8.20
4804.00	53.08	PK	18	1.1	V	-1.06	52.02	74.00	-21.98
4804.00	44.85	Ave	18	1.1	V	-1.06	43.79	54.00	-10.21
7206.00	42.31	PK	242	1.1	Н	1.33	43.64	74.00	-30.36
7206.00	38.65	Ave	242	1.1	Н	1.33	39.98	54.00	-14.02
2321.44	45.36	PK	34	1.1	V	-13.19	32.17	74.00	-41.83
2321.44	37.50	Ave	34	1.1	V	-13.19	24.31	54.00	-29.69
2354.68	42.80	PK	304	1.1	Н	-13.14	29.66	74.00	-44.34
2354.68	36.33	Ave	304	1.1	Н	-13.14	23.19	54.00	-30.81
2483.55	43.64	PK	347	1.6	V	-13.08	30.56	74.00	-43.44
2483.55	38.84	Ave	347	1.6	V	-13.08	25.76	54.00	-28.24

Frequency	Receiver Reading	Detector	Turn table Angle	RX Antenna		Corrected	Corrected		
				Height	Polar	Factor	Amplitude	Limit	Margin
(MHz)	(dBµV)	(PK/QP/Ave)	Degree	(m)	(H/V)	(dB)	(dBµV/m)	(dBµV/m)	(dB)
GFSK Middle Channel									
100.47	21.15	QP	217	1.7	Н	14.15	35.30	40.00	-4.70
100.47	17.49	QP	28	1.8	V	14.15	31.64	40.00	-8.36
4882.00	54.24	PK	237	1.8	V	-0.62	53.62	74.00	-20.38
4882.00	45.27	Ave	237	1.8	V	-0.62	44.65	54.00	-9.35
7323.00	40.36	PK	140	1.6	Н	2.21	42.57	74.00	-31.43
7323.00	38.69	Ave	140	1.6	Н	2.21	40.90	54.00	-13.10
2327.92	45.86	PK	270	1.8	V	-13.19	32.67	74.00	-41.33
2327.92	38.27	Ave	270	1.8	V	-13.19	25.08	54.00	-28.92
2366.74	44.46	PK	47	1.6	Н	-13.14	31.32	74.00	-42.68
2366.74	37.18	Ave	47	1.6	Н	-13.14	24.04	54.00	-29.96
2492.43	42.12	PK	191	1.4	V	-13.08	29.04	74.00	-44.96
2492.43	38.58	Ave	191	1.4	V	-13.08	25.50	54.00	-28.50

Frequency	Receiver Reading	Detector	Turn table Angle	RX Antenna		Corrected	Corrected		
				Height	Polar	Factor	Amplitude	Limit	Margin
(MHz)	(dBµV)	(PK/QP/Ave)	Degree	(m)	(H/V)	(dB)	(dBµV/m)	(dBµV/m)	(dB)
	GFSK High Channel								
100.47	21.49	QP	91	1.3	Н	14.15	35.64	40.00	-4.36
100.47	17.38	QP	215	1.5	V	14.15	31.53	40.00	-8.47
4960.00	53.21	PK	323	1.3	V	-0.24	52.97	74.00	-21.03
4960.00	46.27	Ave	323	1.3	V	-0.24	46.03	54.00	-7.97
7440.00	40.28	PK	234	1.1	Н	2.84	43.12	74.00	-30.88
7440.00	37.94	Ave	234	1.1	Н	2.84	40.78	54.00	-13.22
2338.52	45.18	PK	291	1.6	V	-13.19	31.99	74.00	-42.01
2338.52	39.52	Ave	291	1.6	V	-13.19	26.33	54.00	-27.67
2383.27	44.15	PK	293	1.7	Н	-13.14	31.01	74.00	-42.99
2383.27	36.92	Ave	293	1.7	Н	-13.14	23.78	54.00	-30.22
2498.42	42.74	PK	26	1.3	V	-13.08	29.66	74.00	-44.34
2498.42	37.20	Ave	26	1.3	V	-13.08	24.12	54.00	-29.88

Test Frequency: 18GHz~25GHz

The measurements were more than 20 dB below the limit and not reported

Reference No.: WTS14S0716067E Page 19 of 65

8 Band Edge Measurement

Test Requirement: Section 15.247(d) In addition, radiated emissions which fall in

the restricted bands. as defined in Section 15.205(a), must also comply with the radiated emission limits specified in Section

15.209(a) (see Section 15.205(c)).

Test Method: DA 00-705
Test Mode: Transmitting

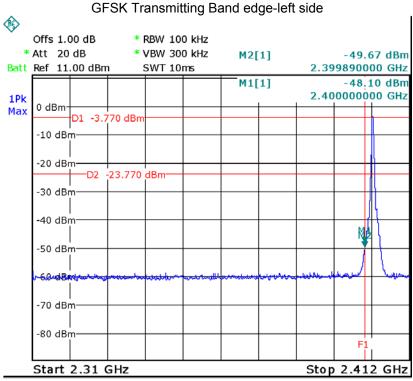
8.1 Test Procedure

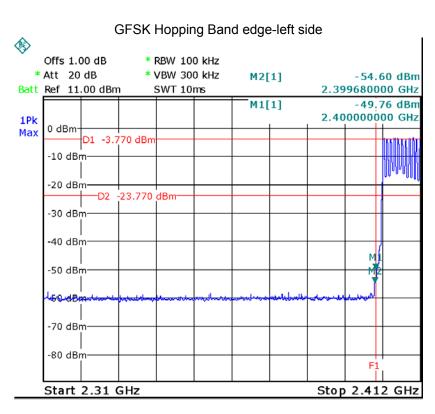
1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum;

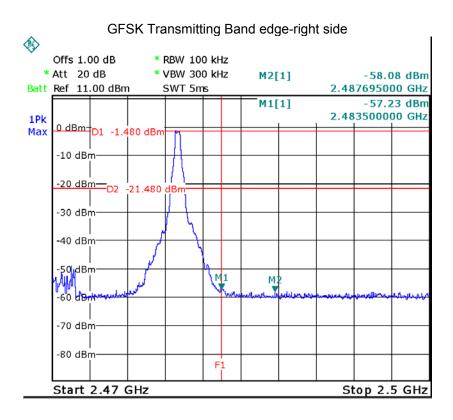
2. Set the spectrum analyzer: RBW = 100kHz, VBW = 300kHz, Sweep = auto Detector function = peak, Trace = max hold

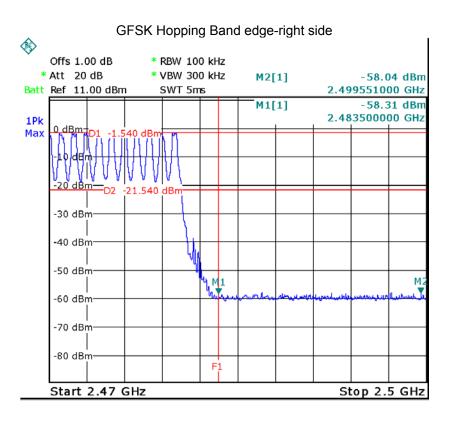
8.2 Test Result

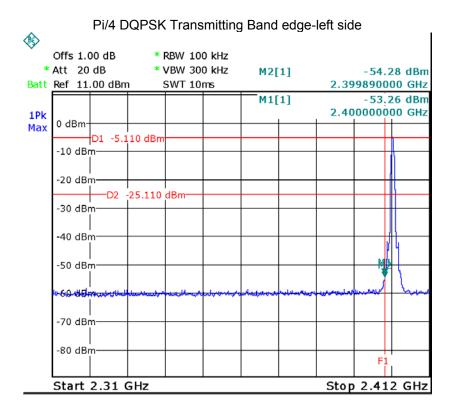
Test plots

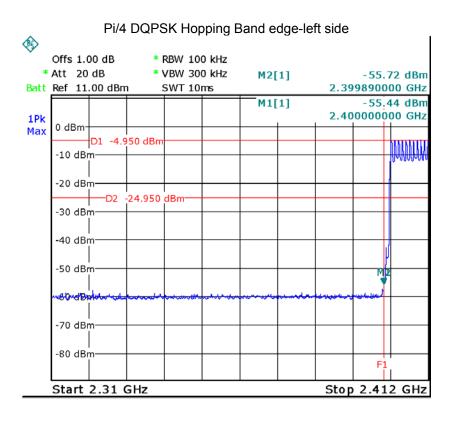


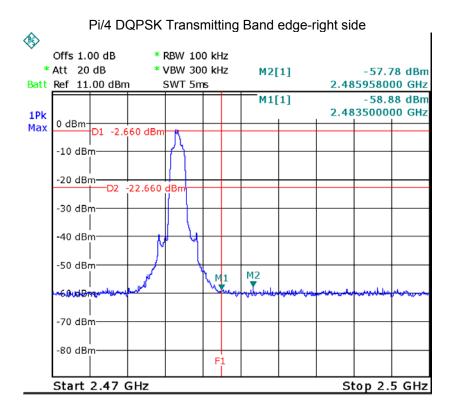




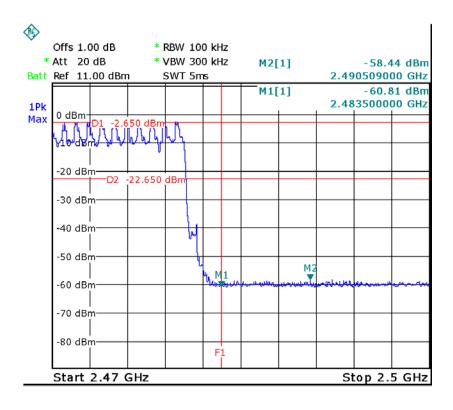


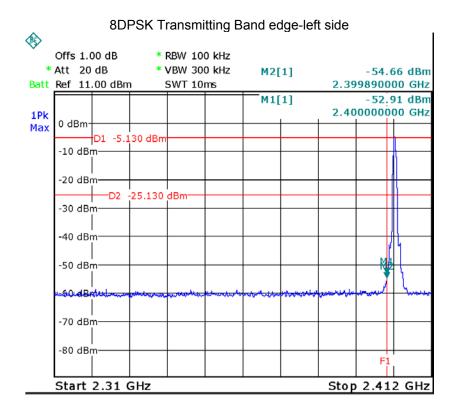


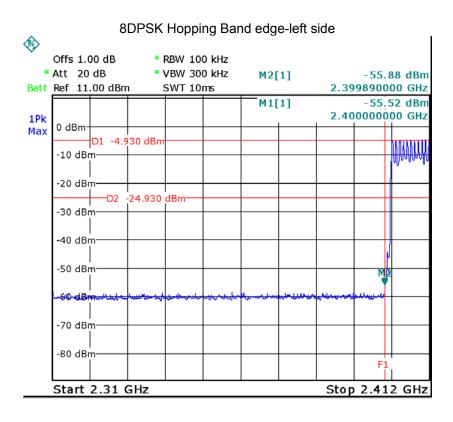


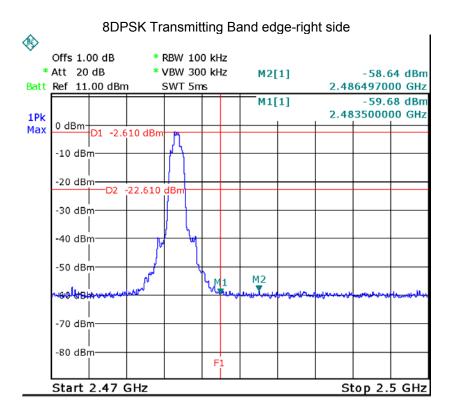


Pi/4 DQPSK Hopping Band edge-right side

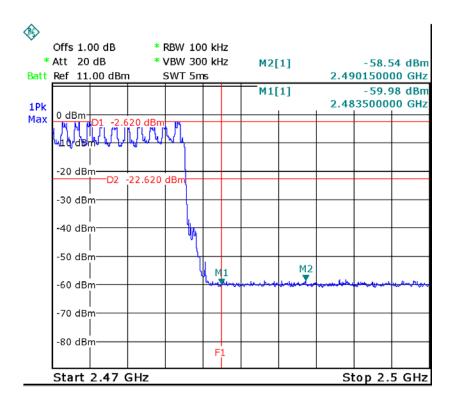








8DPSK Hopping Band edge-right side



Reference No.: WTS14S0716067E Page 26 of 65

9 20 dB Bandwidth Measurement

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: DA 00-705

Test Mode: Test in fixing operating frequency at low, Middle, high channel.

9.1 Test Procedure

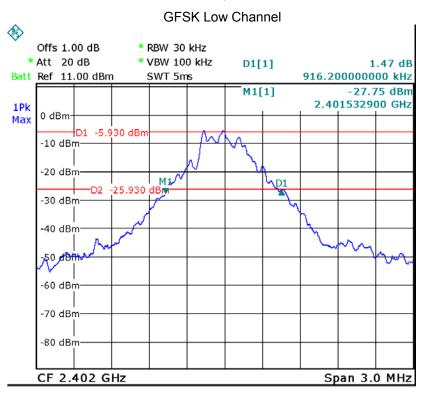
1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum;

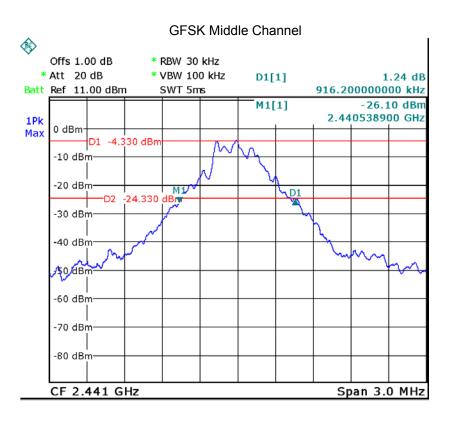
2. Set the spectrum analyzer: RBW = 30kHz, VBW = 100kHz

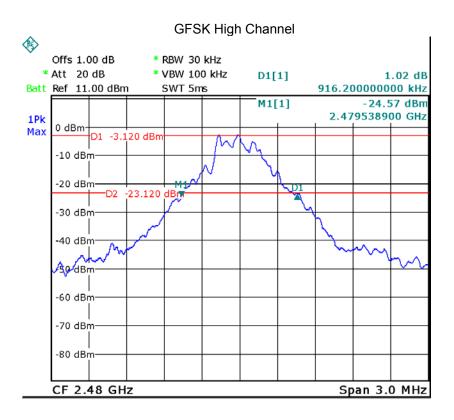
9.2 Test Result

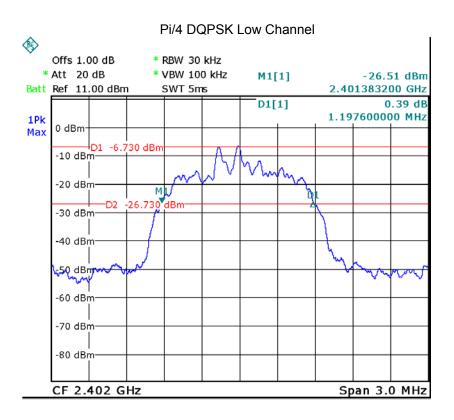
Modulation	Test Channel	Bandwidth	
GFSK	Low	0.916MHz	
GFSK	Middle	0.916MHz	
GFSK	High	0.916MHz	
Pi/4 DQPSK	Low	1.198MHz	
Pi/4 DQPSK	Middle	1.198MHz	
Pi/4 DQPSK	High	1.198MHz	
8DPSK	Low	1.210MHz	
8DPSK	Middle	1.210MHz	
8DPSK	High	1.210MHz	

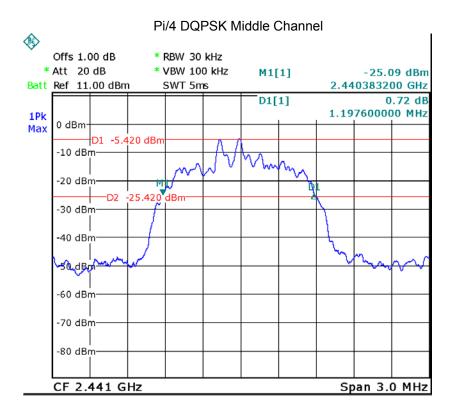
Test plots

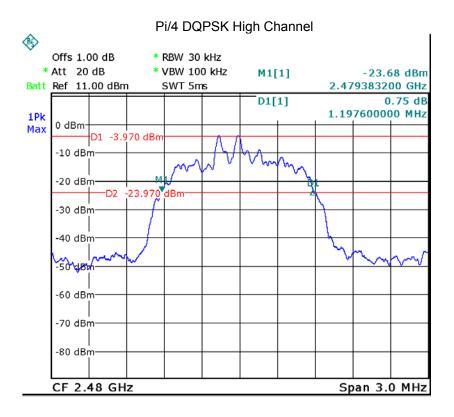


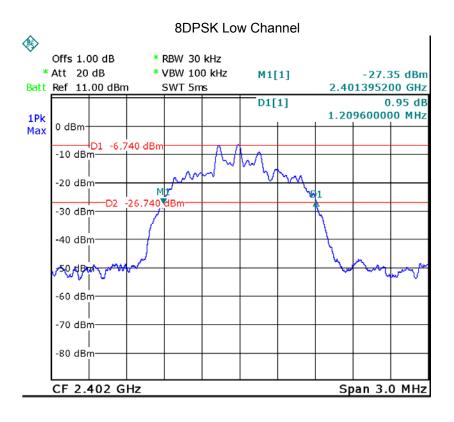


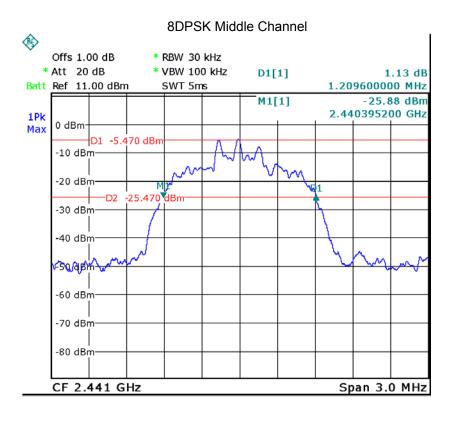


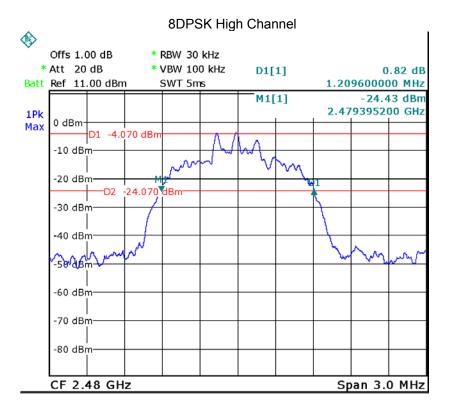












Reference No.: WTS14S0716067E Page 32 of 65

10 Maximum Peak Output Power

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: DA 00-705

Test Limit: Regulation 15.247 (b)(1), For frequency hopping systems

operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz

band: 0.125 watts.

Refer to the result "Number of Hopping Frequency" of this

document. The 1watts (30dBm) limit applies.

Test mode: Test in fixing frequency transmitting mode.

10.1 Test Procedure

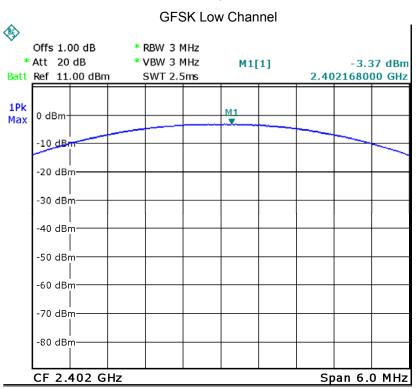
1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

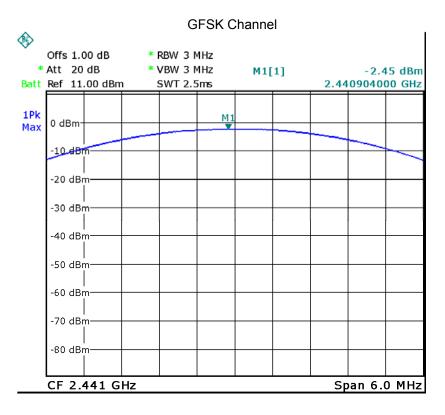
- 2. Set the spectrum analyzer: RBW = 3MHz. VBW = 3MHz. Sweep = auto; Detector Function = Peak.
- 3. Keep the EUT in transmitting at lowest, medium and highest channel individually. Record the max value.

10.2 Test Result

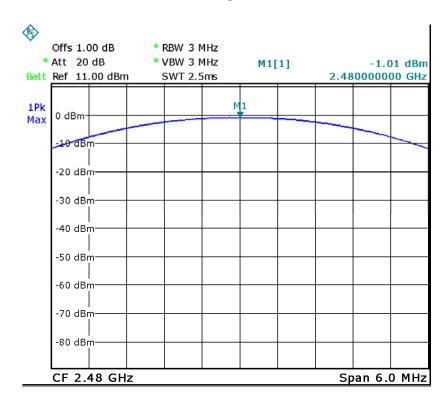
Modulation	Test Channel	Output Power (dBm)	Limit (dBm)	
GFSK	Low	-3.37	30	
GFSK	Middle	-2.45	30	
GFSK	High	-1.01	30	
Pi/4 DQPSK	Low	-4.61	21	
Pi/4 DQPSK	Middle	-3.50	21	
Pi/4 DQPSK	High	-2.07	21	
8DPSK	Low	-4.34	21	
8DPSK	Middle	-3.24	21	
8DPSK	High	-1.89	21	

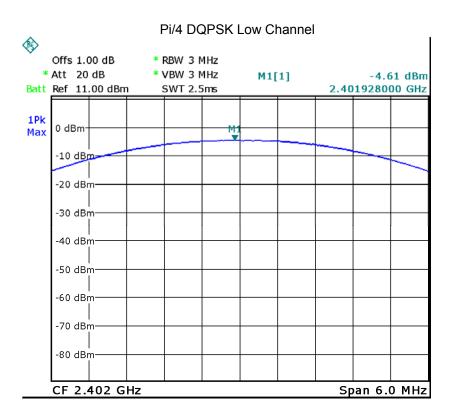
Test plots

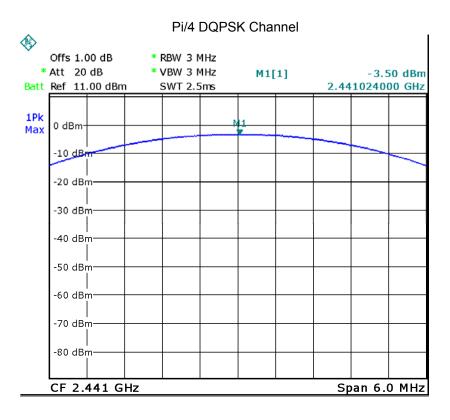




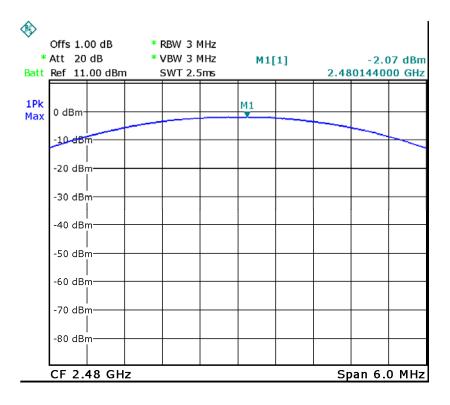
GFSK High Channel

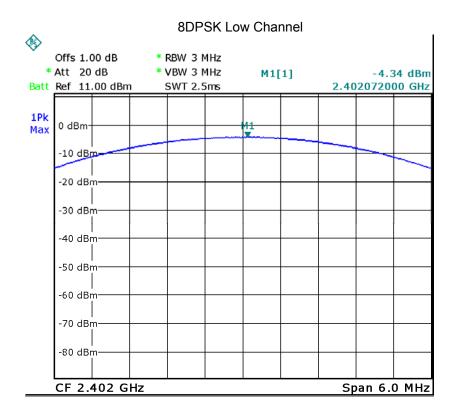


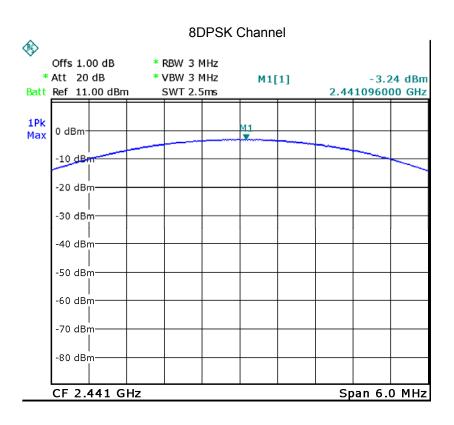




Pi/4 DQPSK High Channel

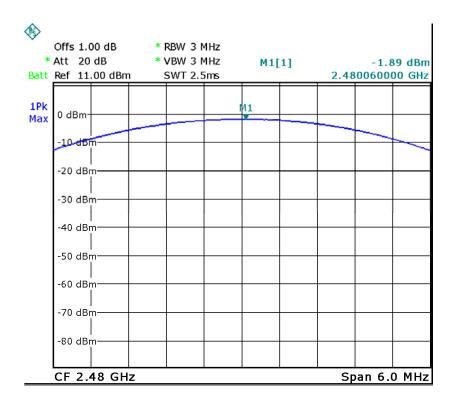






Reference No.: WTS14S0716067E Page 37 of 65

8DPSK High Channel



Reference No.: WTS14S0716067E Page 38 of 65

11 Hopping Channel Separation

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: DA 00-705

Test Limit: Regulation 15.247(a)(1) Frequency hopping systems shall have

hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 1W.

Test Mode: Test in hopping transmitting operating mode.

11.1 Test Procedure

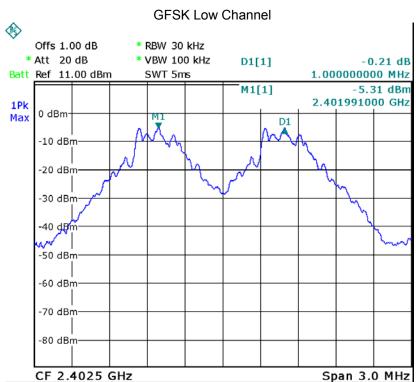
1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

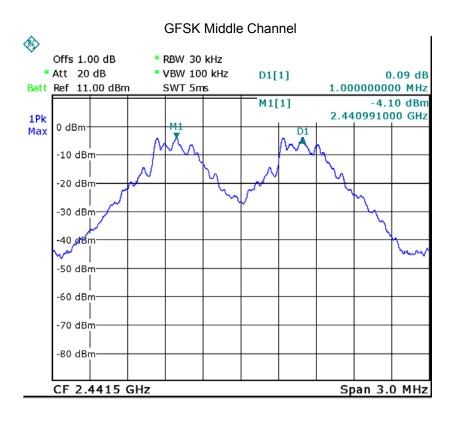
- Set the spectrum analyzer: RBW = 30kHz. VBW = 100kHz , Span = 3.0MHz. Sweep = auto;
 Detector Function = Peak. Trace = Max hold.
- 3. Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. The limit is specified in one of the subparagraphs of this Section Submit this plot.

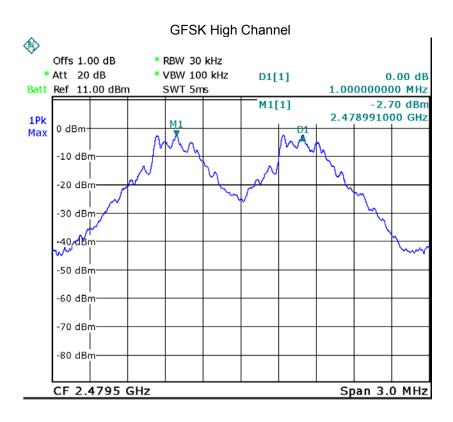
11.2 Test Result

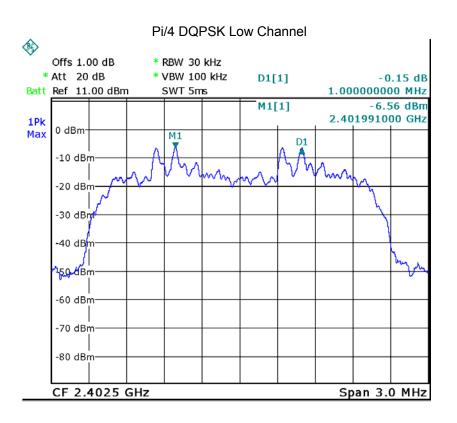
Modulation	Test Channel	Separation (MHz)	Result
GFSK	Low	1.000	PASS
GFSK	Middle	1.000	PASS
GFSK	High	1.000	PASS
Pi/4 DQPSK	Low	1.000	PASS
Pi/4 DQPSK	Middle	1.000	PASS
Pi/4 DQPSK	High	1.000	PASS
8DPSK	Low	1.000	PASS
8DPSK	Middle	1.000	PASS
8DPSK	High	1.000	PASS

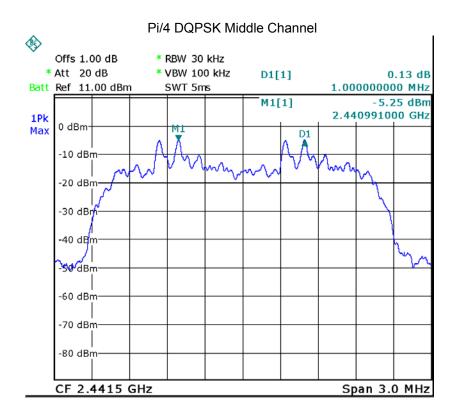
Test plots

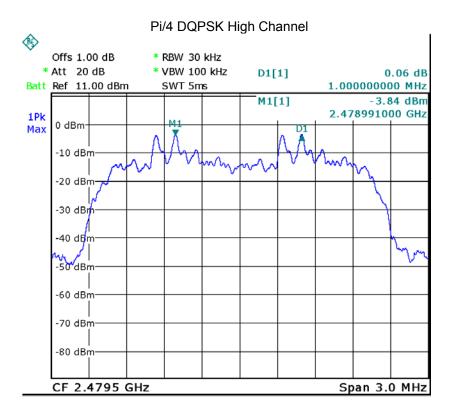


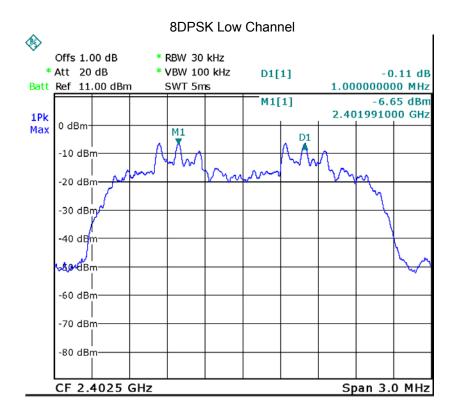


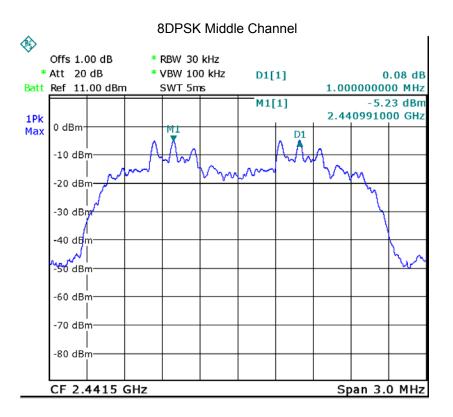


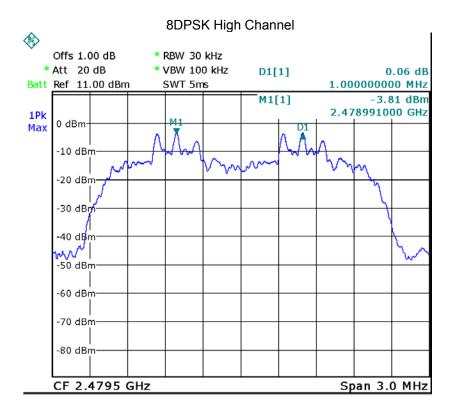












Reference No.: WTS14S0716067E Page 44 of 65

12 Number of Hopping Frequency

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: DA 00-705

Test Limit: Regulation 15.247 (a)(1)(iii) Frequency hopping systems in

the 2400-2483.5 MHz band shall use at least 15 channels.

Test Mode: Test in hopping transmitting operating mode.

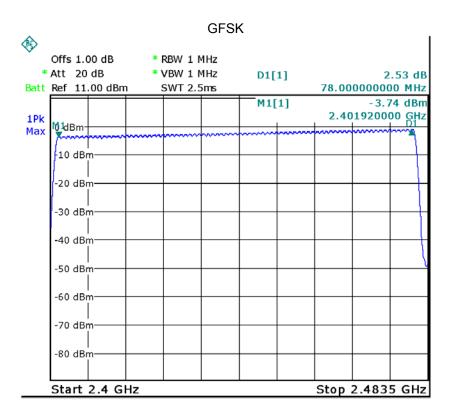
12.1 Test Procedure

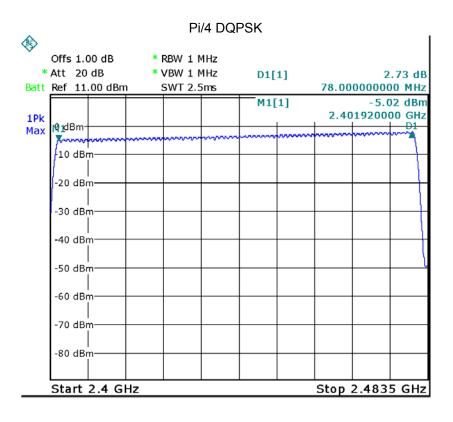
1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

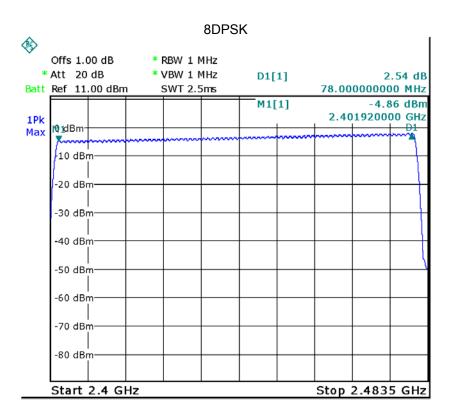
- Set the spectrum analyzer: RBW = 1MHz. VBW = 1MHz. Sweep = auto; Detector Function = Peak. Trace = Max hold.
- 3. Allow the trace to stabilize. It may prove necessary to break the span up to sections. in order to clearly show all of the hopping frequencies. The limit is specified in one of the subparagraphs of this Section.
- 4. Set the spectrum analyzer: Start Frequency = 2.4GHz, Stop Frequency = 2.483GHz. Sweep=auto;

12.2 Test Result

Test Plot: 79 Channels in total







Reference No.: WTS14S0716067E Page 46 of 65

13 Dwell Time

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: DA 00-705

Test Limit: Regulation 15.247(a)(1)(iii) Frequency hopping systems in

the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided

that a minimum of 15 channels are used.

Test Mode: Test in hopping transmitting operating mode.

13.1 Test Procedure

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

- 2. Set spectrum analyzer span = 0. Centred on a hopping channel;
- 3. Set RBW = 1MHz and VBW = 3MHz.Sweep = as necessary to capture the entire dwell time per hopping channel. Set the EUT for DH5, DH3 and DH1 packet transmitting.
- 4. Use the marker-delta function to determine the dwell time. If this value varies with different modes of operation (e.g., data rate, modulation format, etc.), repeat this test for each variation. The limit is specified in one of the subparagraphs of this Section. Submit this plot(s).

13.2 Test Result

DH5 Packet permit maximum 1600 / 79 / 6 hops per second in each channel (5 time slots RX, 1 time slot TX).

DH3 Packet permit maximum 1600 / 79 / 4 hops per second in each channel (3 time slots RX, 1 time slot TX).

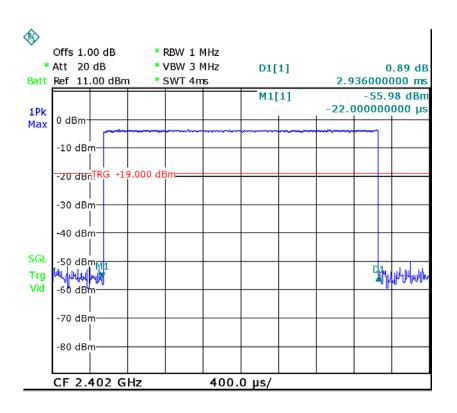
DH1 Packet permit maximum 1600 / 79 /2 hops per second in each channel (1 time slot RX, 1 time slot TX). So, the Dwell Time can be calculated as follows:

Data Packet	Dwell Time(s)	
DH5	1600/79/6*0.4*79*(MkrDelta)/1000	
DH3	1600/79/4*0.4*79*(MkrDelta)/1000	
DH1 1600/79/2*0.4*79*(MkrDelta)/1000		
Remark: Mkr Delta is once pulse time.		

Modulation	Data Packet	Channel	pulse time(ms)	Dwell Time(s)	Limits(s)
		Low	2.936	0.313	0.4
GFSK	DH5	middle	2.936	0.313	0.4
		High	2.936	0.313	0.4
Pi/4DQPSK	DH5	Low	2.936	0.313	0.4
		middle	2.936	0.313	0.4
		High	2.936	0.313	0.4
		Low	2.936	0.313	0.4
8DPSK	DH5	middle	2.936	0.313	0.4
		High	2.936	0.313	0.4

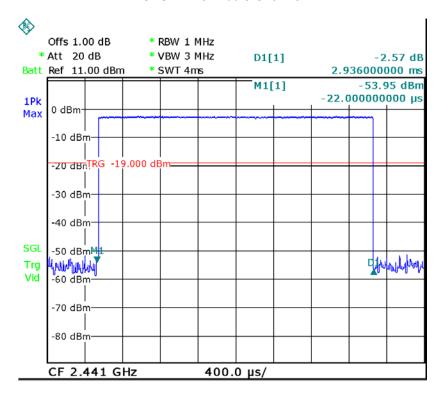
Test Plots

GFSK DH5 Low Channel

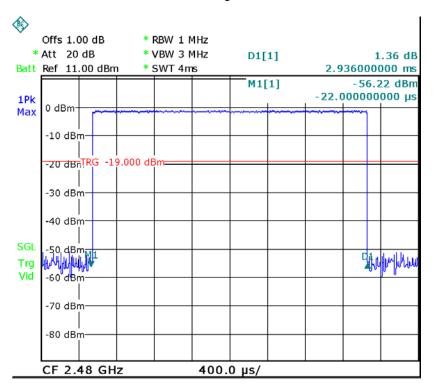


Reference No.: WTS14S0716067E Page 48 of 65

GFSK DH5 Middle Channel

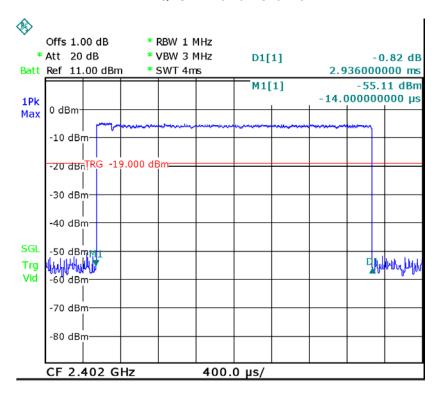


GFSK DH5 High Channel

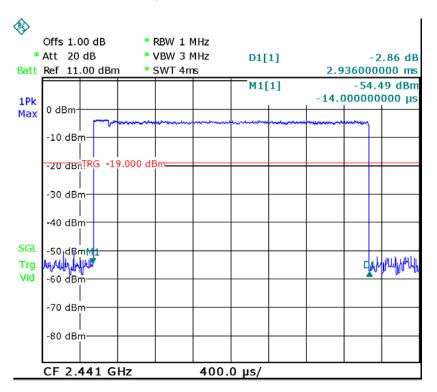


Reference No.: WTS14S0716067E Page 49 of 65

Pi/4DQPSK DH5 Low Channel

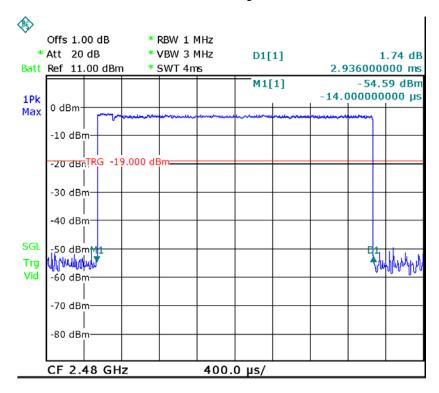


Pi/4DQPSK DH5 Middle Channel

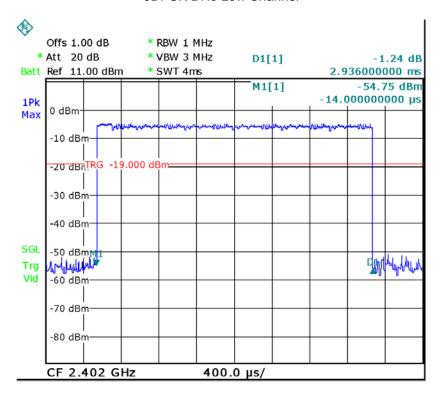


Reference No.: WTS14S0716067E Page 50 of 65

Pi/4DQPSK DH5 High Channel

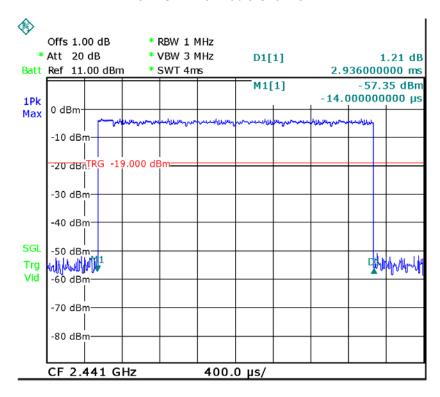


8DPSK DH5 Low Channel

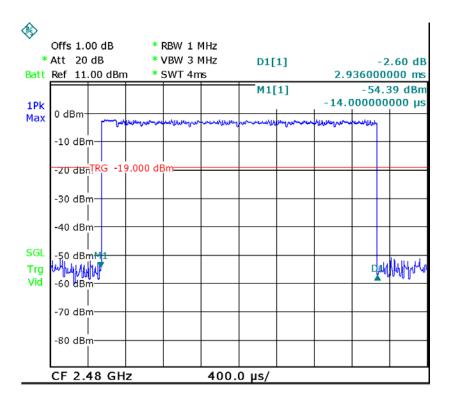


Reference No.: WTS14S0716067E Page 51 of 65

8DPSK DH5 Middle Channel



8DPSK DH5 High Channel



14 Antenna Requirement

According to the FCC Part 15 Paragraph 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. This product has an internal permanent antenna, fulfil the requirement of this section.

Reference No.: WTS14S0716067E Page 53 of 65

15 RF Exposure

Test Requirement: FCC Part 1.1307 Evaluation Method: FCC Part 2.1091

15.1 Requirements

Systems operating under the provisions of this section shall be operated in a manner that ensures that the public is not exposed to radio frequency energy levels in excess limit for maximum permissible exposure. In accordance with 47 CFR FCC Part 2 Subpart J, section 2.1091 this device has been defined as a mobile device whereby a distance of 0.2 m normally can be maintained between the user and the device.

15.2 The procedures / limit

(A) Limits for Occupational / Controlled Exposure

Frequency Range (MHz)	Electric Field Strength (E) (V/m)	Magnetic Field Strength (H) (A/m)	Power Density (S) (mW/ cm²)	Averaging Time E ² , H ² or S (minutes)
0.3-3.0	614	1.63	(100)*	6
3.0-30	1842 / f	4.89 / f	(900 / f)*	6
30-300	61.4	0.163	1.0	6
300-1500			F/300	6
1500-100,000			5	6

(B) Limits for General Population / Uncontrolled Exposure

Frequency Range (MHz)	Electric Field Strength (E) (V/m)	Magnetic Field Strength (H) (A/m)	Power Density (S) (mW/ cm ²)	Averaging Time E ², H ² or S (minutes)
0.3-1.34	614	1.63	(100)*	30
1.34-30	824/f	2.19/f	(180/f)*	30
30-300	27.5	0.073	0.2	30
300-1500			F/1500	30
1500-100,000			1.0	30

Note: f = frequency in MHz; *Plane-wave equivalent power density

Reference No.: WTS14S0716067E Page 54 of 65

15.3 MPE Calculation Method

$${\rm E \ (V/m)} = \frac{\sqrt{30 \times P \times G}}{d} \qquad \qquad {\rm Power \ Density:} \ \ \textit{Pd \ (W/m²)} = \frac{E^2}{377}$$

E = Electric field (V/m)

P = Peak RF output power (W)

G = EUT Antenna numeric gain (numeric)

d = Separation distance between radiator and human body (m)

The formula can be changed to

$$Pd = \frac{30 \times P \times G}{377 \times d^2}$$

From the peak EUT RF output power, the minimum mobile separation distance, d=0.2m, as well as the gain of the used antenna, the RF power density can be obtained

Antenna Gain (numeric)	Peak Output Power (dBm)	Peak Output Power (mW)	Power Density (mW/cm2)	Limit of Power Density (mW/cm2)
1.000	-1.01	0.793	0.000158	1

16 Photographs – Model BTS710 Test Setup

16.1 Photograph – Conducted Emission Test Setup

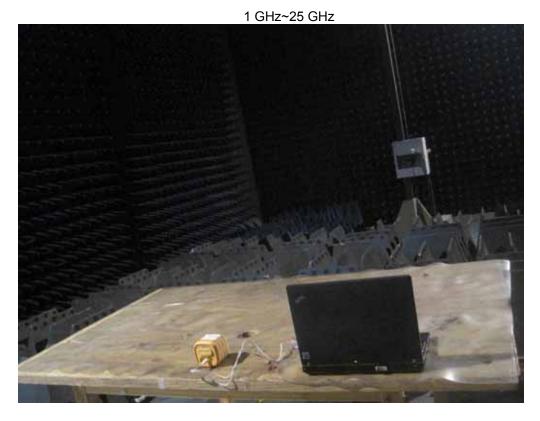


16.2 Photograph – Radiation Spurious Emission Test Setup



Waltek Services (Shenzhen) Co.,Ltd. http://www.waltek.com.cn





17 Photographs - Constructional Details

17.1 Model BTS710- External View





Reference No.: WTS14S0716067E Page 58 of 65





Reference No.: WTS14S0716067E Page 59 of 65





Reference No.: WTS14S0716067E Page 60 of 65





Reference No.: WTS14S0716067E Page 61 of 65



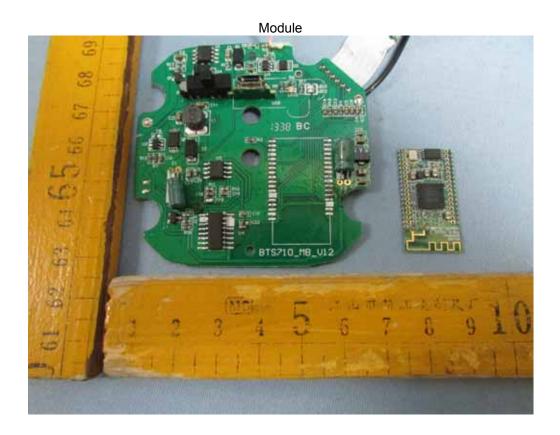
17.2 Model BTS710- Internal View





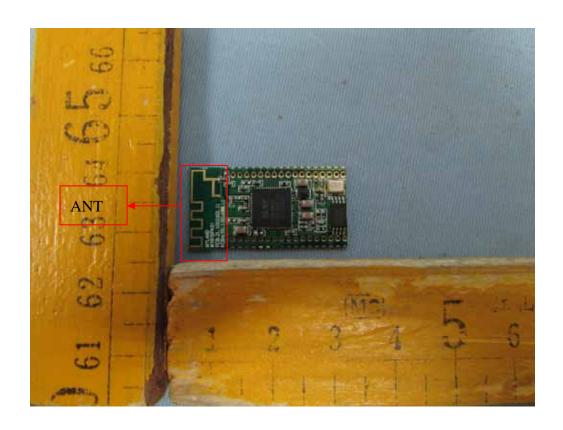
Reference No.: WTS14S0716067E Page 63 of 65





Waltek Services (Shenzhen) Co.,Ltd. http://www.waltek.com.cn

Reference No.: WTS14S0716067E Page 64 of 65





Reference No.: WTS14S0716067E Page 65 of 65



===== End of Report =====